## Agenda 2018 Co-innovation Forum Brisbane October 16 From Edge to Insight - Using Device Data to Define your Process

09:00 - 09:20	Welcome	Gavin French
	Introductions, Technology Advancement	Sales Manager QLD Yokogawa Australia & New Zealand
	& Impact on Process Plants	
09:20 - 10:00	Using Co-Development to Overcome Technology Hurdles	Saurabh Bhandari
		Senior Data Scientist
		Industrial Solutions Research Department Yokogawa Co-innovation Centre Singa
10:00 - 10:30	Turning 4-20mA Process Instruments into Smart Edge Devices	Simon Lillie
		Product Manager Flow & Wireless Yokogawa Australia & New Zealand
	Break	
10:50 - 11:20	Connected by Design	Nick Crowe
	How new Analytical Devices are Designed	Product Manager Analytical Yokogawa Australia & New Zealand
	with Asset Management in Mind	
11:20 - 11:50	Born on the Edge	Tony Farah
	New Generation Field Devices Opening Up	Product Manager Transmitters & Level Yokogawa Australia & New Zealand
	a World of Untapped Process Data	
11:50- 12:30	Customer Panel Forum	Panel Facilitator Sean Cahill
	How New Insights from Edge Devices are Driving Process Change Lunch	Marketing Manager Yokogawa Australia & New Zealand
13:15 - 13:45	An Integrated Approach to Operations	Naoki Ura
	with Process Modelling and Predictive Maintenance	Regional Systems Business Manager
		Yokogawa Headquarters, Tokyo
13:45 - 14:15	The Human Factor	David Walker
	Smart Operator Insights & Decision Making	National Chief Engineer Yokogawa Australia & New Zealand
14:15 - 14:45	Practical IT/OT Convergence &	Russell Byfield
	How Best Practice from Both Can Improve Data Accessibility	Advanced Solutions Manager Yokogawa Australia & New Zealand
	Break	
15:00 - 15:30	Virtualisation & the Cloud	Shalveen Sharma
	A Confronting Transformation of Control System Architecture	Product Manager IA Systems & Solutions Yokogawa Australia & New Zealand
15:30 - 16:10	Customer Panel Forum	Panel Facilitator Sean Cahill
	Effective Cyber Security Deployment	Marketing Manager Yokogawa Australia & New Zealand
	in the Face of Rapid Technology Advancement	0.0